

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10508846	TOMOE ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Kiss, Eric B	2192	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
717	128	07/09/2009	EBK
712	227	07/09/2009	EBK
714	30	07/09/2009	EBK

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
PALM Inventor search	08/09/2007	EBK
EAST (USPAT; US-PGPUB; FPRS; EPO; JPO; DERWENT; IBM_TDB) (see search history printout)	08/09/2007	EBK
www.google.com (see search history printouts)	08/09/2007	EBK
Updated EAST search (see search history printout)	02/01/2008	EBK
www.google.com (search terms: JTAG boundary scan)	02/01/2008	EBK
365/189.02 (txt-limited search)	07/09/2009	EBK

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
	Interference searched (US-PGPUB; txt search; see search history printout)	07/09/2009	EBK